Issue Classification



10564294

zavelna v

Examiner

LEAH S LOVELL

Applicant(s)/Patent Under Reexamination

DE VAAN, ADRIANUS JOHANNES

STEPHANES

Art Unit

2885

ORIGINAL						INTERNATIONAL CLASSIFICATION								
CLASS SUBCLASS					CLAIMED						NON-CLAIMED			
362 622				F	2	1	٧	7 / 22 (2006.01.01)						
CROSS REFERENCE(S)														
CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)				OCK)										
362	606	612	613	620	626									
362	800													
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	Claims renumbered in the same order as presented by applicant						☐ CPA ☐ T.D. ☐ R.1.47								
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1	15	17												
2	2	6	18												
3	3	16	19												
4	4	17	20												
5	5	18	21												
7	6	19	22												
8	7	20	23												
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10	11														
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12	13														
13	14														
-	15														
14	16														

/LEAH S LOVELL/ Examiner.Art Unit 2885	6 Nov '08	Total Claims Allowed: 20		
(Assistant Examiner)	(Date)			
/Jong-Suk (James) Lee/	11/6/08	O.G. Print Claim(s)	O.G. Print Figure	
(Primary Examiner)	(Date)	1	3,2	

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